

## N-Channel 20-V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY			
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
20	0.039 at V <sub>GS</sub> = 4.5 V	6	6 nC
	0.045 at V <sub>GS</sub> = 2.5 V	6	
	0.055 at V <sub>GS</sub> = 1.8 V	6	

SCHOTTKY PRODUCT SUMMARY		
V <sub>KA</sub> (V)	V <sub>F</sub> (V) Diode Forward Voltage	I <sub>F</sub> (A) <sup>a</sup>
20	0.375 at 1 A	1

### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- LITTLE FOOT<sup>®</sup> Plus Power MOSFET
- New Thermally Enhanced PowerPAK<sup>®</sup> ChipFET<sup>®</sup> Package
  - Small Footprint Area
  - Low On-Resistance
  - Thin 0.8 mm Profile
- Compliant to RoHS Directive 2002/95/EC

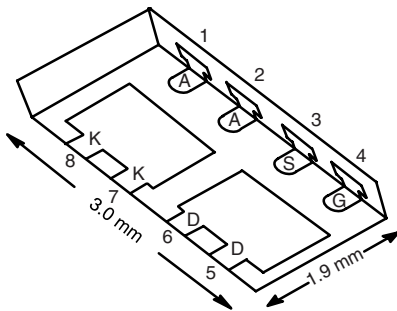


**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

### APPLICATIONS

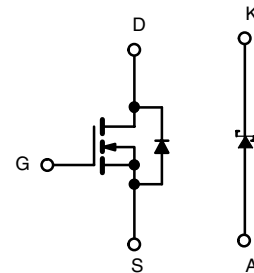
- Load Switch for Portable Applications
- Ideal for Boost Circuits

PowerPAK ChipFET Dual



Bottom View

Marking Code



N-Channel MOSFET

Ordering Information: Si5858DU-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage (MOSFET)	V <sub>DS</sub>	20	V	
Reverse Voltage (Schottky)	V <sub>KA</sub>	20		
Gate-Source Voltage (MOSFET)	V <sub>GS</sub>	± 8		
Continuous Drain Current (T <sub>J</sub> = 150 °C) (MOSFET)	I <sub>D</sub>	T <sub>C</sub> = 25 °C	6 <sup>a</sup>	A
		T <sub>C</sub> = 70 °C	6 <sup>a</sup>	
		T <sub>A</sub> = 25 °C	7.2 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	5.8 <sup>b, c</sup>	
Pulsed Drain Current (MOSFET)	I <sub>DM</sub>	20	A	
Continuous Source Current (MOSFET Diode Conduction)	I <sub>S</sub>	T <sub>C</sub> = 25 °C		6.9
		T <sub>A</sub> = 25 °C	1.9 <sup>b, c</sup>	
Average Forward Current (Schottky)	I <sub>F</sub>	1 <sup>b</sup>	A	
Pulsed Forward Current (Schottky)	I <sub>FM</sub>	7		
Maximum Power Dissipation (MOSFET)	P <sub>D</sub>	T <sub>C</sub> = 25 °C	8.3	W
		T <sub>C</sub> = 70 °C	5.3	
		T <sub>A</sub> = 25 °C	2.3 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	1.5 <sup>b, c</sup>	
Maximum Power Dissipation (Schottky)	P <sub>D</sub>	T <sub>C</sub> = 25 °C	7.8	W
		T <sub>C</sub> = 70 °C	5	
		T <sub>A</sub> = 25 °C	2.1 <sup>b, c</sup>	
		T <sub>A</sub> = 70 °C	1.3 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient (MOSFET) <sup>b, f</sup>	$t \leq 5$ s	$R_{thJA}$	45	55	°C/W
Maximum Junction-to-Case (Drain) (MOSFET)		$R_{thJC}$	12	15	
Maximum Junction-to-Ambient (Schottky)	$t \leq 5$ s	$R_{thJA}$	49	61	
Maximum Junction-to-Case (Drain) (Schottky)		$R_{thJC}$	13	16	

## Notes:

- Package limited.
- Surface Mounted on FR4 board.
- $t = 5$  s.
- See Solder Profile ([www.vishay.com/ppg?73257](http://www.vishay.com/ppg?73257)). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- Maximum under Steady State conditions for MOSFETS is 105 °C/W.
- Maximum under Steady State conditions for Schottky is 110 °C/W.

SPECIFICATIONS $T_J = 25$ °C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ V, $I_D = 250$ $\mu$ A	20			V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS/TJ}$	$I_D = 250$ $\mu$ A		17.4		mV/°C
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)/TJ}$			- 2.6		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250$ $\mu$ A	0.4		1.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0$ V, $V_{GS} = \pm 8$ V			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 20$ V, $V_{GS} = 0$ V			- 1	$\mu$ A
		$V_{DS} = 20$ V, $V_{GS} = 0$ V, $T_J = 55$ °C			- 10	
On-State Drain Current <sup>a</sup>	$I_{D(on)}$	$V_{DS} \leq 5$ V, $V_{GS} = 4.5$ V	- 20			A
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(on)}$	$V_{GS} = 4.5$ V, $I_D = 4.4$ A		0.032	0.039	$\Omega$
		$V_{GS} = 2.5$ V, $I_D = 4.1$ A		0.037	0.045	
		$V_{GS} = 1.8$ V, $I_D = 1.8$ A		0.0455	0.055	
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 10$ V, $I_D = 4.4$ A		22		S
<b>Dynamic<sup>b</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 10$ V, $V_{GS} = 0$ V, $f = 1$ MHz		520		pF
Output Capacitance	$C_{oss}$			100		
Reverse Transfer Capacitance	$C_{rss}$			60		
Total Gate Charge	$Q_g$	$V_{DS} = 10$ V, $V_{GS} = 8$ V, $I_D = 4.4$ A		10.5	16	nC
		$V_{DS} = 10$ V, $V_{GS} = 4.5$ V, $I_D = 4.4$ A		6	9	
Gate-Source Charge	$Q_{gs}$			0.91		
Gate-Drain Charge	$Q_{gd}$			0.7		
Gate Resistance	$R_g$	$f = 1$ MHz		1.9		$\Omega$
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10$ V, $R_L = 2.8$ $\Omega$ $I_D \cong 3.6$ A, $V_{GEN} = 4.5$ V, $R_g = 1$ $\Omega$		20	30	ns
Rise Time	$t_r$			65	100	
Turn-Off Delay Time	$t_{d(off)}$			40	60	
Fall Time	$t_f$			10	15	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10$ V, $R_L = 2.8$ $\Omega$ $I_D \cong 3.6$ A, $V_{GEN} = 8$ V, $R_g = 1$ $\Omega$		5	10	
Rise Time	$t_r$			12	20	
Turn-Off Delay Time	$t_{d(off)}$			26	40	
Fall Time	$t_f$			8	15	



<b>SPECIFICATIONS</b> $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$			14.8	A
Pulse Diode Forward Current	$I_{SM}$				20	
Body Diode Voltage	$V_{SD}$	$I_S = 1.2\text{ A}, V_{GS} = 0\text{ V}$		0.8	1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = -2\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$		45	70	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			21	32	nC
Reverse Recovery Fall Time	$t_a$			29		ns
Reverse Recovery Rise Time	$t_b$			16		

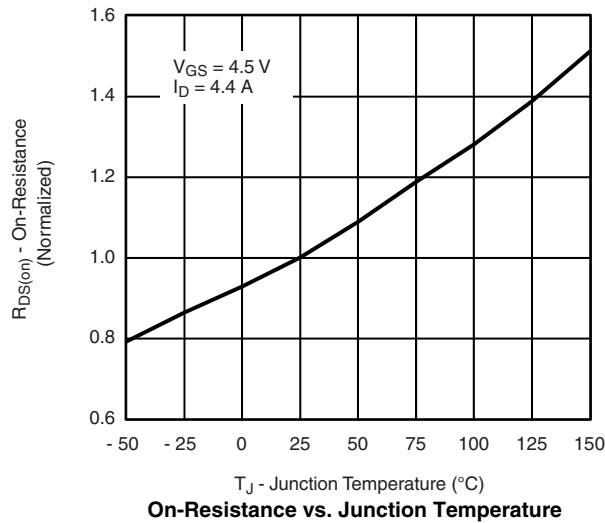
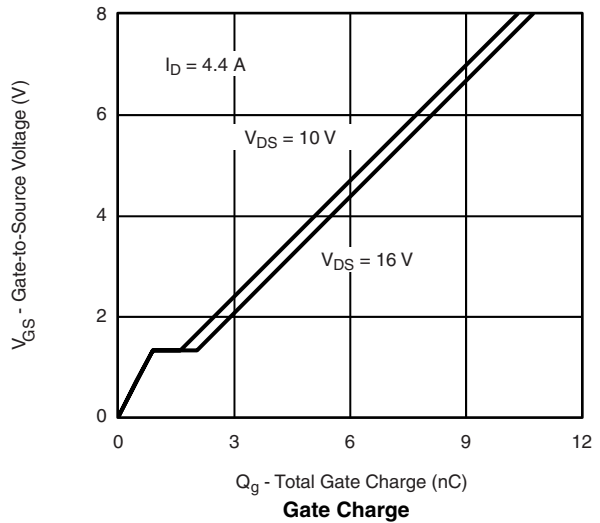
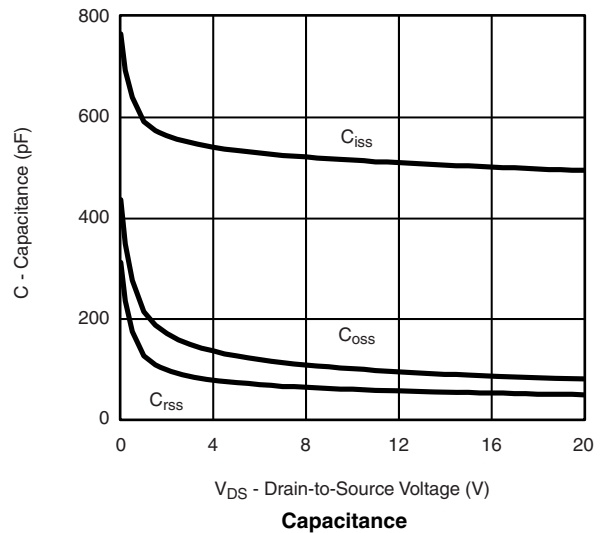
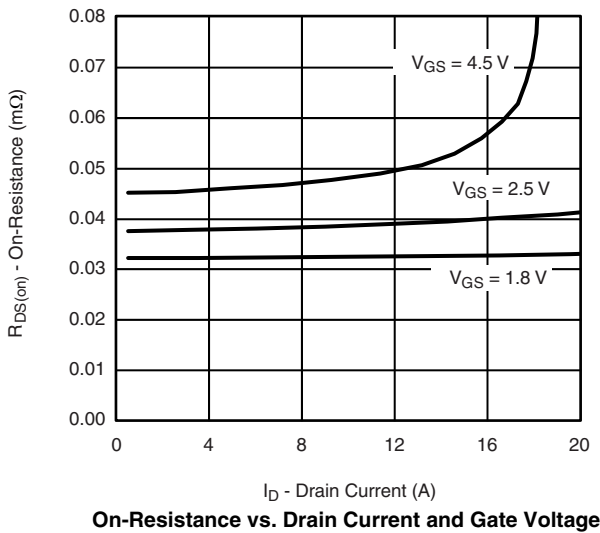
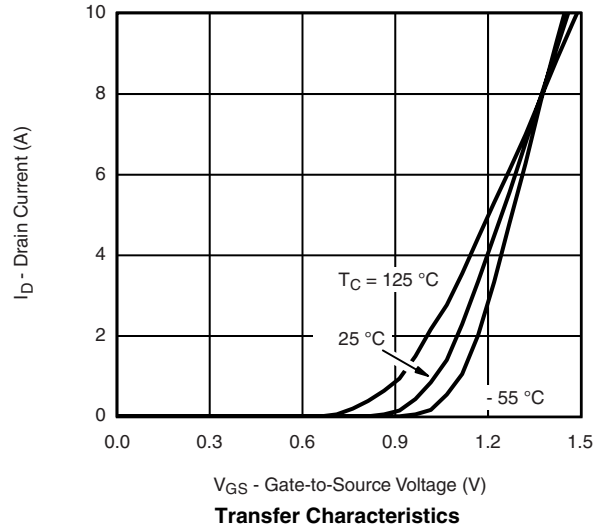
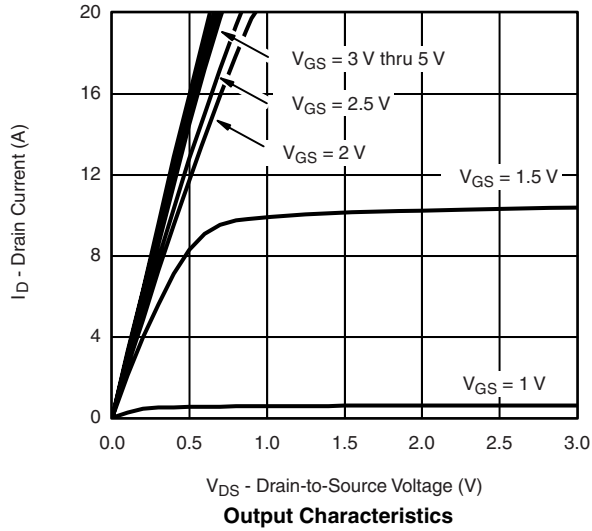
Notes:

- a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.

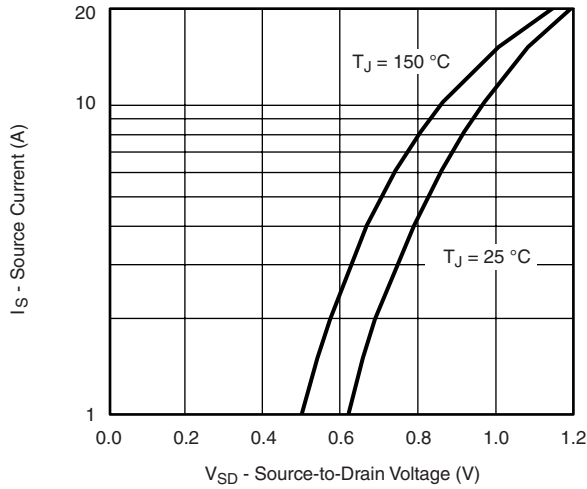
<b>SCHOTTKY SPECIFICATIONS</b> $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	$V_F$	$I_F = 1\text{ A}$		0.34	0.375	V
		$I_F = 1\text{ A}, T_J = 125\text{ }^\circ\text{C}$		0.255	0.290	
Maximum Reverse Leakage Current	$I_{rm}$	$V_R = 20\text{ V}$		0.05	0.500	mA
		$V_R = 20\text{ V}, T_J = 85\text{ }^\circ\text{C}$		2	20	
		$V_R = 20\text{ V}, T_J = 125\text{ }^\circ\text{C}$		10	100	
Junction Capacitance	$C_T$	$V_R = 10\text{ V}$		90		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

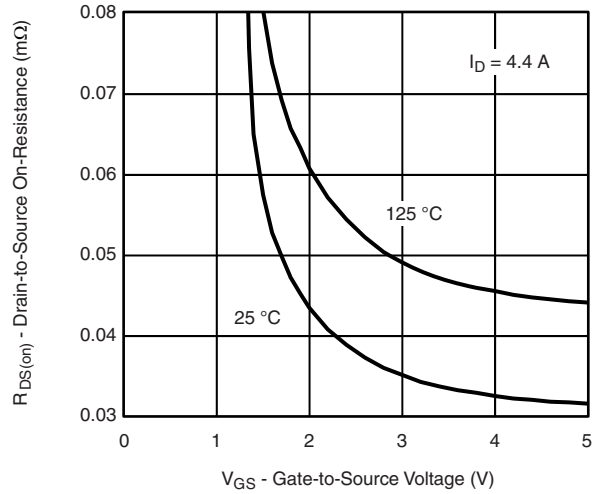
**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



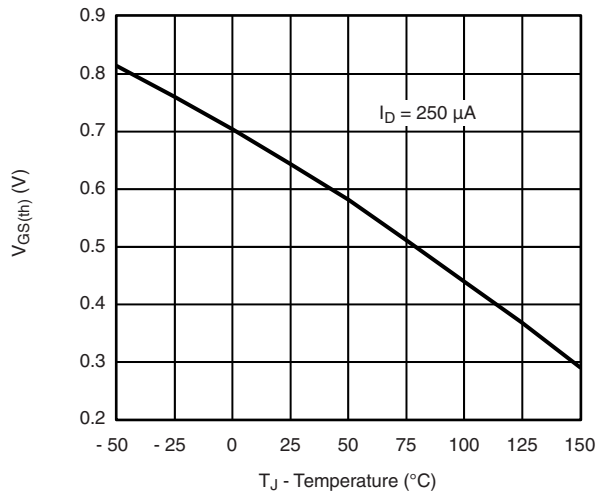
**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



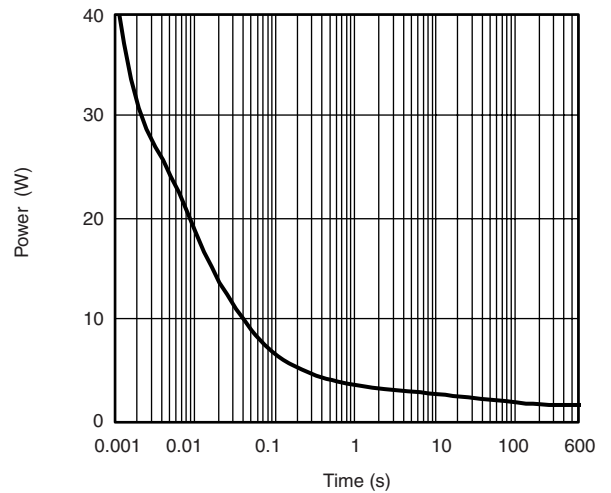
**Source-Drain Diode Forward Voltage**



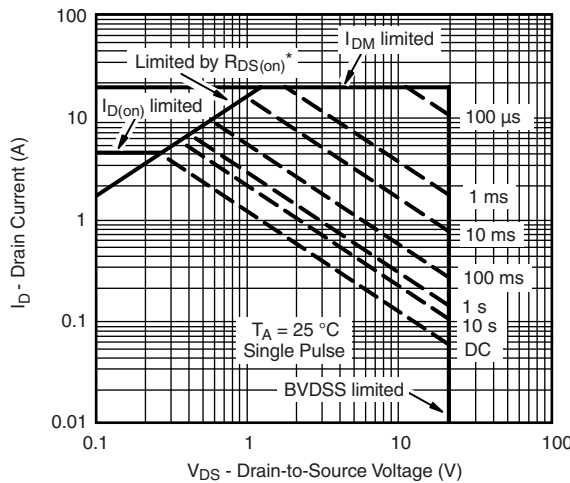
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**



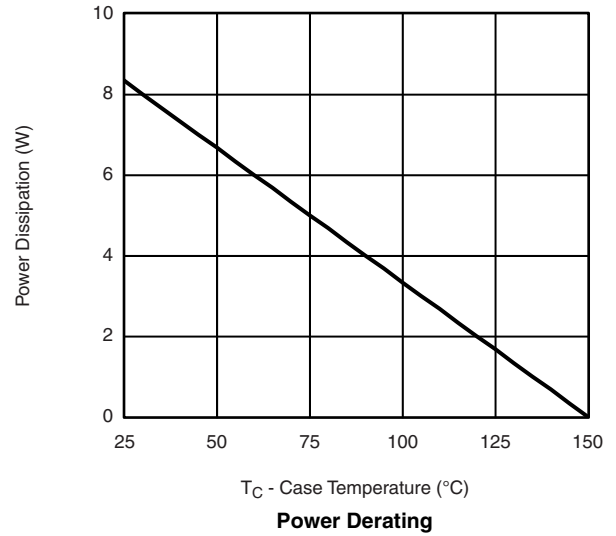
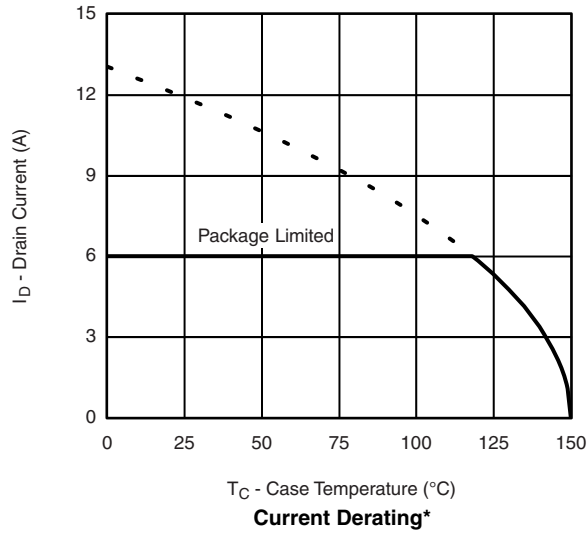
**Single Pulse Power, Junction-to-Ambient**



\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

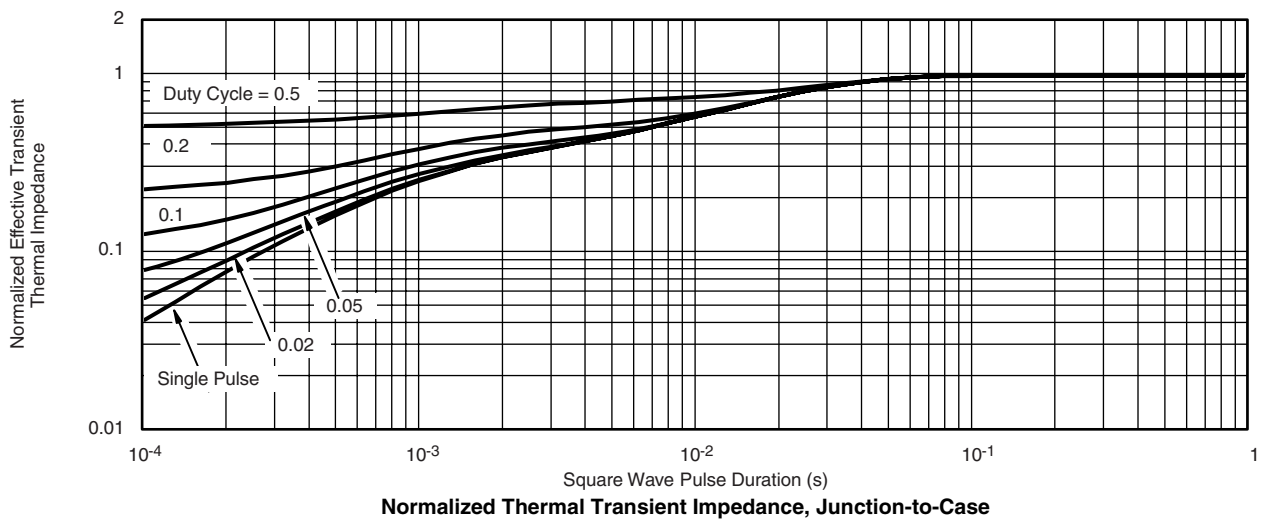
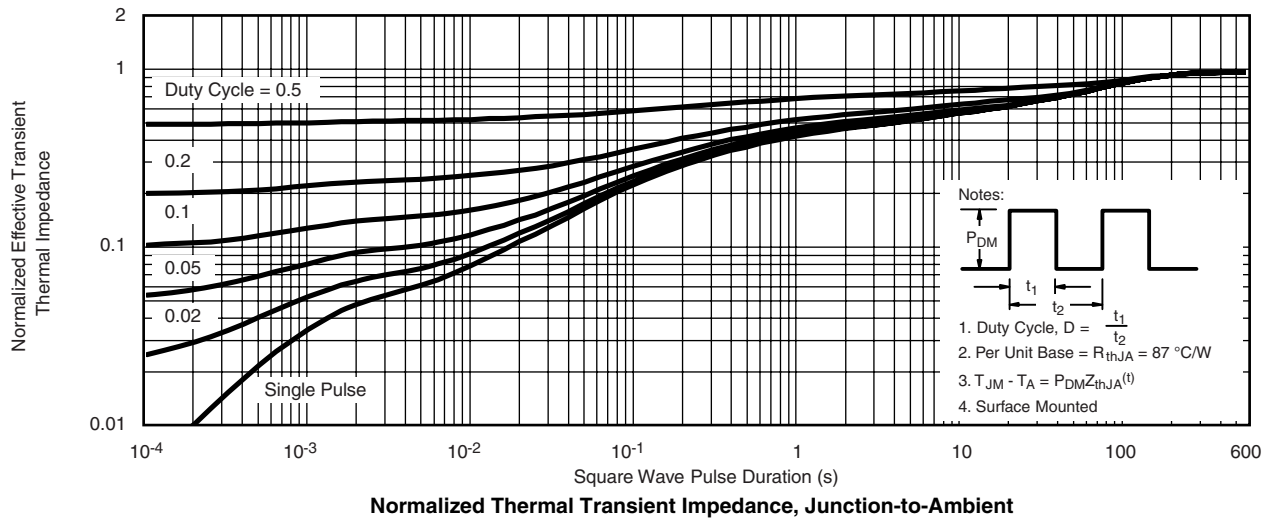
**Safe Operating Area, Junction-to-Ambient**

**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

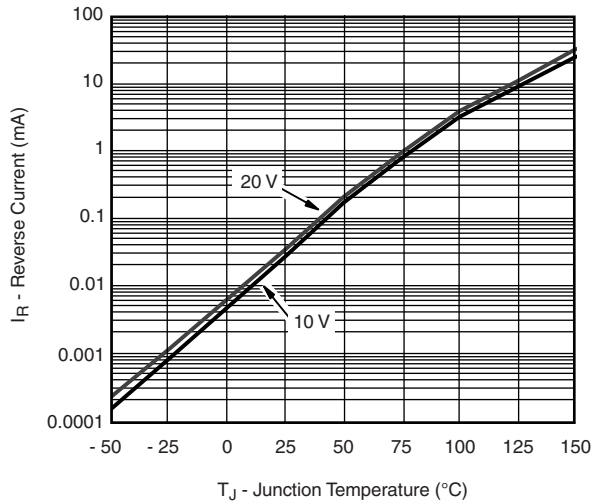


\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

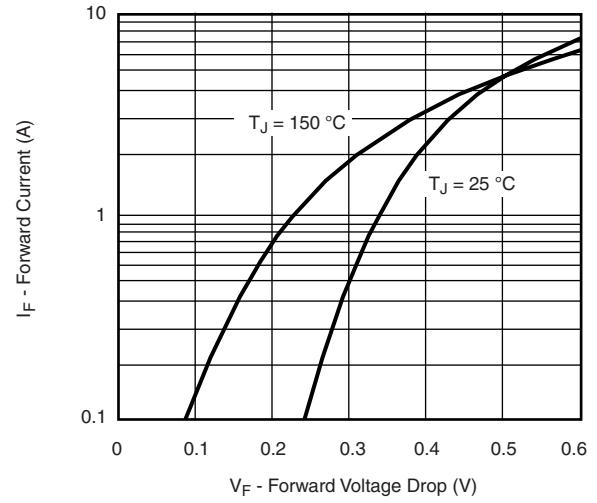
**MOSFET TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



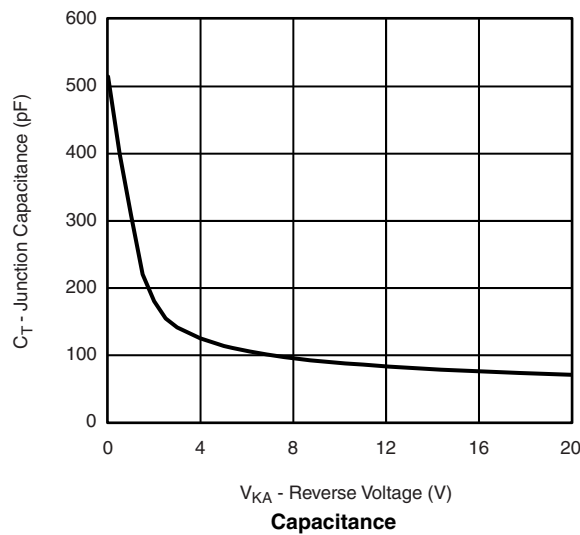
**SCHOTTKY TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



**Reverse Current vs. Junction Temperature**



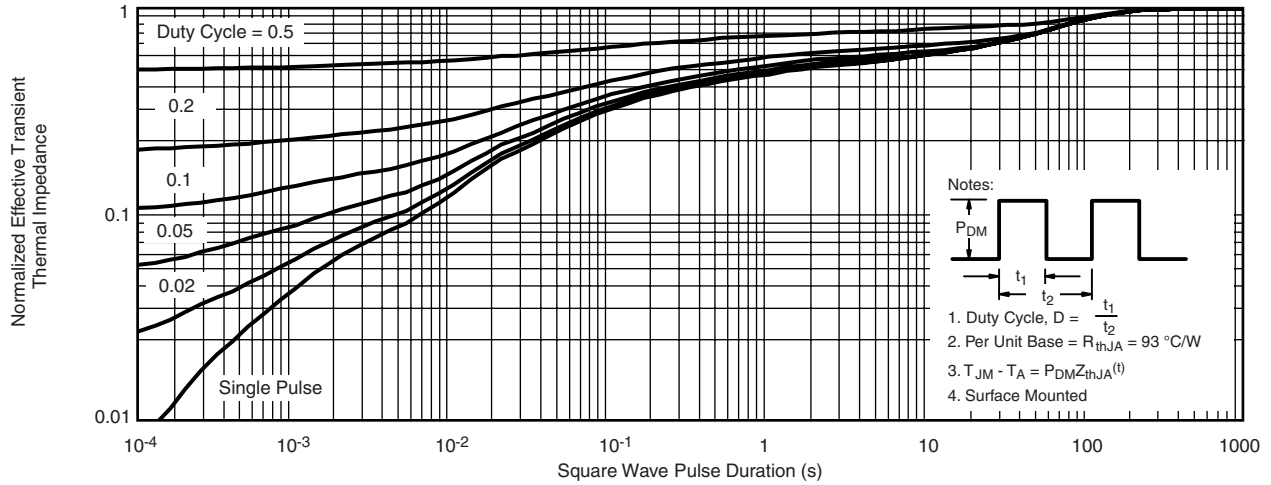
**Forward Voltage Drop**



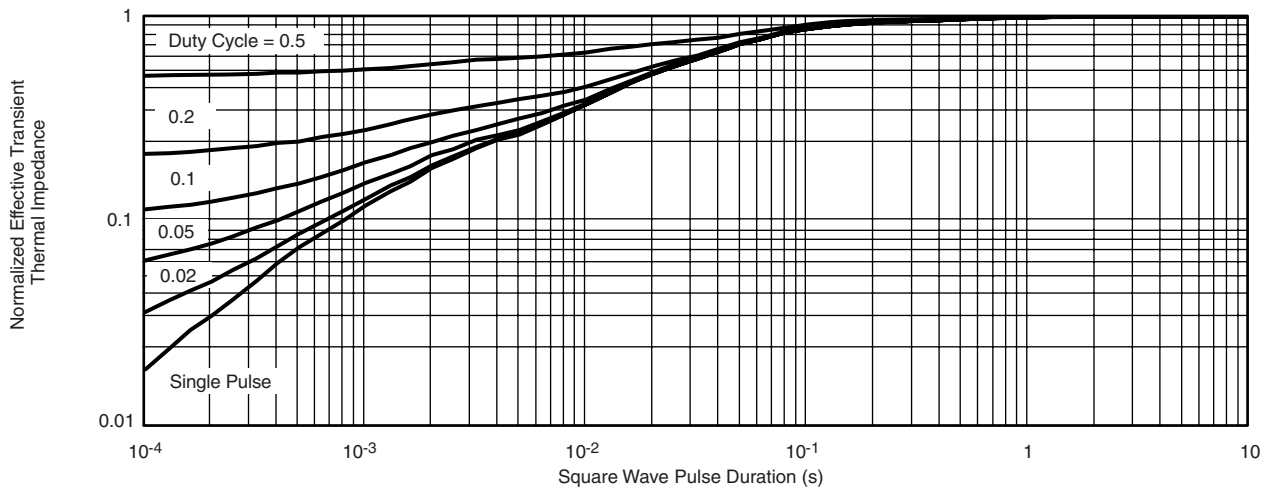
**Capacitance**



**SCHOTTKY TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Foot**

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